


<b>Search Notes</b> 	<b>Application/Control No.</b> 10665374	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> IQBAL H CHOWDHURY	<b>Art Unit</b> 1652

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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STN and WEST Databases- updated search of 4/27/2007	6/20/2008	IC

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